SIC Fee Structure

Instruments (Condition)	Analysis Charges	
	Academic Institution	Industries
1. Single Crystal X-ray Diffraction Facility	7.63.6511161116111611	
Data collection and structure solution up to publication level	7000/-	60,000/-
Low temperature (Liquid Nitrogen) charges	2000/-	15,000/-
Laboratory charges (crystallization attempts if required)	2000/	25,000/-
For NON-SAARC Countries (per sample in Eu	ro, exclusive of taxes)	25,000/
Data collection and structure solution up to publication level with Low		2000/
temperature (Liquid Nitrogen)	750/-	3000/-
2. NMR Spectroscopy		
	(Raw FID files)	
Proton NMR	200/-	500/-
13C & other X-Nuclei & 2D NMR (For first hour of data collection)	300/-	700/-
	(Proper report in	n PDF format)
Proton NMR	500/-	800/-
13C & other X-Nuclei & 2D NMR (For first hour of data collection)	1000/-	1200/-
For subsequent hours	200/-	500/-
Temperature variability range 25°C to 120°C For high temperature data collection (extra charges)	500/-	2000/-
Temperature variability range 25°C to -70°C For Low temperature (Liquid Nitrogen) charges	500/-	2000/-
Structure Elucidation (Detailed report of Peak Assignment based on structure will be given)	2500/-	5000/-
Solvent charges extra at actu	al cost	
D2O / CDCl3 / DMSO-d6 / MeOD / CD3COCD3		200/-
All other solvents		300/-
3. Powder X-ray diffraction Facility (PXRD)		
Per hour of data collection	2000/-	5000/-
4. Chromatography		
LC-MS	1000/-	2000/-
GC-MS	2000/-	5000/-
HPLC	1000/-	1500/-
HRMS	1000/-	1500/-
5. Thermal Analysis	1000/	1300/
	1000/-	2000/-
Thermo Gravimetric Analysis (TGA)	·	5000/-
Differential Scanning Calorimetery (DSC)	3000/-	5000/-
5. Elemental Analysis (CHNS-O)		/
C,H,N,S Analysis	1000/-	2000/-
Oxygen Analysis	500/-	1500/-
7. BET Surface Area Analyzer		
	Physisorption/Chemisoprtion	
Measurement based on N 2 Gas	5000/-	10,000/-
Measurement based on CO 2, and H 2 gases	8000/-	16,000/-
Measurement based on mixture of gases :5%H 2 $\&$ 95%N 2 , 5% Oxygen $\&$ 95% He and 20% Ammonia $\&$ 80% He	10,000/-	20,000/-
	Micropore Analysis	
Measurement based on N 2 Gas	10,000/-	20,000/-
Measurement based on CO 2 , and H 2 gases	16,000/-	32,000/-

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Measurement based on mixture of gases :5%H 2 & 95%N 2 , 5% Oxygen & 95% He and 20% Ammonia & 80% He	20,000/-	40,000/-	
8. Spectroscopy			
FT-IR	500/-	1000/-	
UV-Visible	500/-	1000/-	
UV-Vis-NIR	500/-	1000/-	
Fluorescence	500/-	1000/-	
Circular Dichroism (CD)	1000/-	2000/-	
9. Atomic Force Mocroscopy/ Scanning Probe Microscopy (AFM/SPM)			
Measuring modes	(Processed image up to the publication level will be provided)		
Semi-Contact & Contact Mode	1000/-	2000/-	
Conductive	5000/-	15000/-	
Magnetic Force Microscopy (MFM)	5000/-	15000/-	
Kelvin Probe (Surface Potential Microscopy)	5000/-	15000/-	
Electric Force Microscopy (EFM)	5000/-	15000/-	
Scanning Tunneling Microscopy (STM)	5000/-	15000/-	
10. Field Emission - Scanning Electron Microscope (FE-SEM)			
	(Per sample for first hour of recording)		
FE-SEM	1000/-	2000/-	
EDS/EDX	2000/-	3500/-	
WDS/WDX	2500/-	10,000/-	
11. Confocal Laser Scanning Microscope (CLSM)			
Operations	(Per Hour)		
Confocal Imaging	1000/-	1500/-	
FLIM/FCS	1000/-	3000/-	
Live Cell Imaging	4000/-	10,000/-	
Multiphoton Imaging	1500/-	3000/-	
12. Dual ion Beam Sputtering Desposition (DIBSD)			
For precious/noble metals	8000/-	60,000/-	
For Semiconductors	7000/-	50,000/-	
For dielectrics	5000/-	40,000/-	
13. Four Probe Hall Mesurement System			
For precious/noble metals	1000/-	4000/-	
14. Solar Simulator & Quantum Efficiency Mesurement System			
For VOC,ISC and PCE measurments	5000/-	20,000/-	
For VOC,ISC and PCE, internal and external quantum efficiencies measurments	10,000/-	50,000/-	
15. Annealing Furnace	· ·	, ,	
For annealing under vaccum	1000/-	40,000/-	
For annealing under argon/nitrogen/oxygen	2000/-	6000/-	
16. Variable-Angel, variable-wavelength Spectroscopic Transmission, Reflection & Ell		3330/	
For transmission, reflection and thickness measurements	2000/-	6000/-	
For transmission, reflection and thickness measurements For transmission, reflection, thickness and ellipsometry measurements	4000/-	10,000/-	
	+000/	10,000/-	
17. Photo-Luminescence (PL)	500/-	2000/-	
For Room Temp PL	1000/-	3000/-	
For Low Temp PL	1000/-	3000/-	
18. Extended X-Ray absorption fine structure (EXAFS)			

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Per sample for first hour of recording	2000/-	4000/-	
Data Recording for subsequent hour	500/-	1000/-	
Data Analysis & Interpretation	2500/-	5000/-	
19. Other Equipmets			
Polarimeter	500/-	1000/-	
Labconco Lyophilizer	750/-	1500/-	
Rheometer	500/-	1000/-	
Langmuir–Blodgett film deposition system	500/-	1000/-	
20. Single Molecule Imaging, Using total Internal Reflection Fluorescence Microscopy (TIRFM)			
TIRFM	500/-	2500/-	
21. Microwave Reactor			
Per hour	200/-	1000/-	
22. Cylclic Voltammetry (CV)			
Per hour	500/-	1000/-	
23. Liquid Nitrogen (Ln2)			
Per Litre *At a time Maximum of 400Litre will be delivered.*	31/-	37/-	
Transportation to be arranged by the buyer themselves.			
Thanks for Visitiing.			

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